Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/944,103	FUKAWA ET AL.
Examiner	Art Unit
Tianjie Chen	2656

SEARCHED			
Class	Subclass	Date	Examiner
360	132	5/8/2006	TJ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEAF (INCLUDING S	RCH NOTE SEARCH S	S TRATEGY)
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East Report		5/8/2006	TJ